

<b>Notice of References Cited</b>	Application/Control No. 10/549,726		Applicant(s)/Patent Under Reexamination DELISLE, GILLES L.	
	Examiner Richard L. Chiesa		Art Unit 1797	Page 1 of 4

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	Examiner Richard L. Chiesa		Art Unit 1797	Page 2 of 4

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<b>Notice of References Cited</b>	Application/Control No. 10/549,726	Applicant(s)/Patent Under Reexamination DELISLE, GILLES L.	
	Examiner Richard L. Chiesa	Art Unit 1797	Page 3 of 4

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	Examiner Richard L. Chiesa		Art Unit 1797	Page 4 of 4

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	D	US-			
	E	US-			
	F	US-			
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